



FORM PTO-1449	ATTY. DKT NO.	24-009-TB-RCE	SER. NO.	10/690,811
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	APPLICANT	NOGAMI		
	FILING DATE	Oct. 23, 2003	GROUP	1616

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
	5,824,339	10/20/98	Shimizu et al.		
	2005/0089548	4/28/05	Virgalitto et al.		
	5,456,745	10/10/95	Roreger et al.		
	7,115,280	10/3/06	Hanna et al.		

## FOREIGN PATENT DOCUMENTS

Examiner INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	TRANSLATION	
								NO	Eng. Abstract
	JP-A-09-132522	5/20/97	JAPAN						X
	JP-A-10-029932	2/3/98	JAPAN						X
	WO 00/35448	6/22/00	PCT						
	JP-A-2001-028074	1/30/01	JAPAN						X
	JP-A-2001-288074	10/16/01	JAPAN						X

## OTHER REFERENCES

EXAMINER INITIAL	(include Author, Title, Date, Pertinent Pages, etc.)
	Office Action dated July 31, 2008 in corresponding U.S. application No. 11/540,952.
	International Search Report dated July 12, 2005 in PCT application No. PCT/JP2005/004569 (and English translation).
	Office Action dated August 4, 2008 in corresponding U.S. application No. 11/540,954.
	International Search Report dated July 12, 2005 in PCT application No. PCT/JP2005/004568 (and English translation).

EXAMINER	DATE CONSIDERED
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
	2007/0141153	6/21/07	Nogami		
	6,136,344	10/24/00	Depui et al.		
	5,582,838	12/10/96	Rork et al.		
	2007/0141152	6/21/07	Nogami		
	2007/0202171	8/30/07	Nogami		
	6,020,706	2/1/00	Iwashita et al.		

## FOREIGN PATENT DOCUMENTS

## TRANSLATION

Examiner INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
								Eng. Abstract	
	JP-A-01-272520	10/31/89	JAPAN					X	(Abs. Only)
	JP-A-03-106813	5/7/91	JAPAN					X	(Abs. Only)
	JP-A-2005-080838	3/31/05	JAPAN					X	(Abs. Only)
	JP-A-2004-196784	7/15/04	JAPAN					X	(Abs. Only)
	WO 02/087622	11/7/02	PCT					X	

## OTHER REFERENCES

EXAMINER INITIAL	(include Author, Title, Date, Pertinent Pages, etc.)
	Office Action dated September 12, 2008 in corresponding U.S. application No. 10/592,953.

EXAMINER	DATE CONSIDERED